

# AOP800

## Dual N-Channel Enhancement Mode Field Effect Transistor

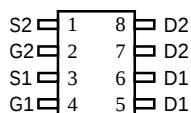
### General Description

The AOP800 uses advanced trench technology to provide excellent  $R_{DS(ON)}$  and low gate charge. This device is suitable for use as a load switch or in PWM applications. *Standard Product AOP800 is Pb-free (meets ROHS & Sony 259 specifications).*

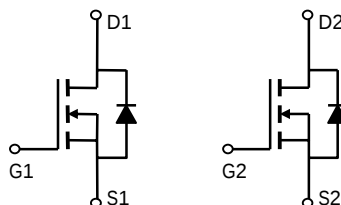
### Features

$V_{DS} (V) = 30V$   
 $I_D = 9A \quad (V_{GS} = 10V)$   
 $R_{DS(ON)} < 20m\Omega \quad (V_{GS} = 10V)$   
 $R_{DS(ON)} < 28m\Omega \quad (V_{GS} = 4.5V)$

**UIS TESTED!**  
***Rg, Ciss, Coss, Crss Tested***



**PDIP-8**



### Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

| Parameter                                      | Symbol           | Maximum    | Units      |
|------------------------------------------------|------------------|------------|------------|
| Drain-Source Voltage                           | $V_{DS}$         | 30         | V          |
| Gate-Source Voltage                            | $V_{GS}$         | $\pm 20$   | V          |
| Continuous Drain Current <sup>A</sup>          | $I_D$            | 9          | A          |
|                                                | $T_A=70^\circ C$ | 7.3        |            |
| Pulsed Drain Current <sup>B</sup>              | $I_{DM}$         | 30         |            |
| Power Dissipation                              | $P_D$            | 2.5        | W          |
|                                                | $T_A=70^\circ C$ | 1.6        |            |
| Avalanche Current <sup>B</sup>                 | $I_{AR}$         | 16         | A          |
| Repetitive avalanche energy 0.3mH <sup>B</sup> | $E_{AR}$         | 38         | mJ         |
| Junction and Storage Temperature Range         | $T_J, T_{STG}$   | -55 to 150 | $^\circ C$ |

### Thermal Characteristics

| Parameter                                | Symbol          | Typ | Max | Units        |
|------------------------------------------|-----------------|-----|-----|--------------|
| Maximum Junction-to-Ambient <sup>A</sup> | $R_{\theta JA}$ | 40  | 50  | $^\circ C/W$ |
| Maximum Junction-to-Ambient <sup>A</sup> |                 | 67  | 80  | $^\circ C/W$ |
| Maximum Junction-to-Lead <sup>C</sup>    | $R_{\theta JL}$ | 33  | 40  | $^\circ C/W$ |

Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

| Symbol                      | Parameter                             | Conditions                                                                                | Min | Typ        | Max      | Units |
|-----------------------------|---------------------------------------|-------------------------------------------------------------------------------------------|-----|------------|----------|-------|
| <b>STATIC PARAMETERS</b>    |                                       |                                                                                           |     |            |          |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage        | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V                                                | 30  |            |          | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =30V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                         |     |            | 1<br>5   | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> = ±20V                                               |     |            | 100      | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                | V <sub>DS</sub> =V <sub>GS</sub> I <sub>D</sub> =250μA                                    | 1.4 | 1.7        | 3        | V     |
| I <sub>D(ON)</sub>          | On state drain current                | V <sub>GS</sub> =10V, V <sub>DS</sub> =5V                                                 | 30  |            |          | A     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance     | V <sub>GS</sub> =10V, I <sub>D</sub> =9A<br>T <sub>J</sub> =125°C                         |     | 16<br>22.3 | 20<br>27 | mΩ    |
|                             |                                       | V <sub>GS</sub> =4.5V, I <sub>D</sub> =7.3A                                               |     | 22         | 28       | mΩ    |
| g <sub>FS</sub>             | Forward Transconductance              | V <sub>DS</sub> =5V, I <sub>D</sub> =9A                                                   |     | 23         |          | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                 | I <sub>S</sub> =1A, V <sub>GS</sub> =0V                                                   |     | 0.75       | 1        | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current |                                                                                           |     |            | 3        | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                       |                                                                                           |     |            |          |       |
| C <sub>iss</sub>            | Input Capacitance                     | V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz                                         |     | 940        | 1250     | pF    |
| C <sub>oss</sub>            | Output Capacitance                    |                                                                                           |     | 150        |          | pF    |
| C <sub>rss</sub>            | Reverse Transfer Capacitance          |                                                                                           |     | 119        |          | pF    |
| R <sub>g</sub>              | Gate resistance                       | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz                                          |     | 0.5        | 1.5      | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                       |                                                                                           |     |            |          |       |
| Q <sub>g(10V)</sub>         | Total Gate Charge                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =9A                            |     | 18         | 24       | nC    |
| Q <sub>g(4.5V)</sub>        | Total Gate Charge                     |                                                                                           |     | 9          | 12       | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                    |                                                                                           |     | 3.4        |          | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                     |                                                                                           |     | 4.7        |          | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, R <sub>L</sub> =1.7Ω,<br>R <sub>GEN</sub> =3Ω |     | 5          | 6.5      | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                     |                                                                                           |     | 6          | 7.5      | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                    |                                                                                           |     | 19         | 25       | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                    |                                                                                           |     | 4.5        | 6        | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time      | I <sub>F</sub> =9A, dI/dt=100A/μs                                                         |     | 16.7       | 21       | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =9A, dI/dt=100A/μs                                                         |     | 6.7        | 10       | nC    |

A: The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The value in any given application depends on the user's specific board design.

B: Repetitive rating, pulse width limited by junction temperature.

C. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to lead R<sub>θJL</sub> and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The SOA curve provides a single pulse rating.

F. The current rating is based on the t<sub>s</sub> ≤ 10s thermal resistance rating.

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## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

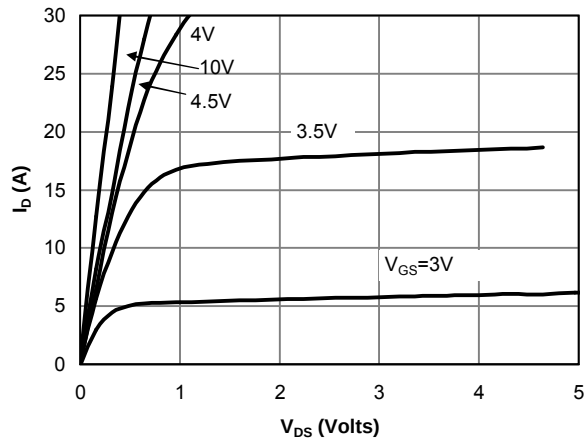


Figure 1: On-Region Characteristics

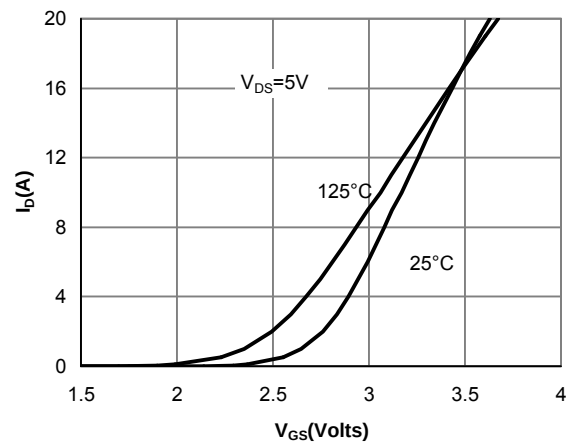


Figure 2: Transfer Characteristics

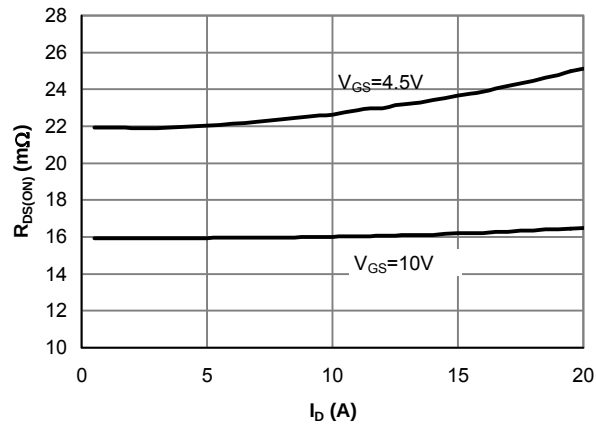


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

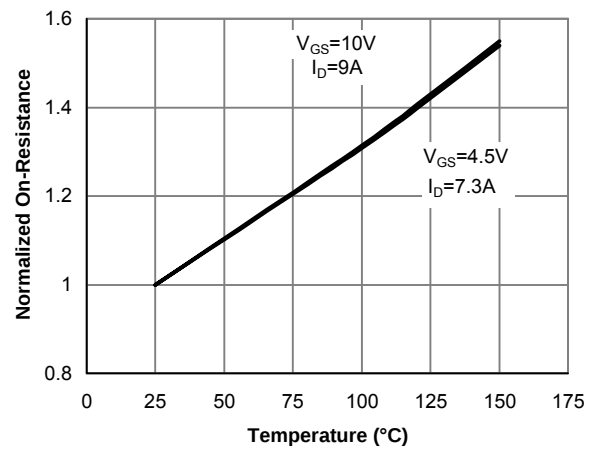


Figure 4: On-Resistance vs. Junction Temperature

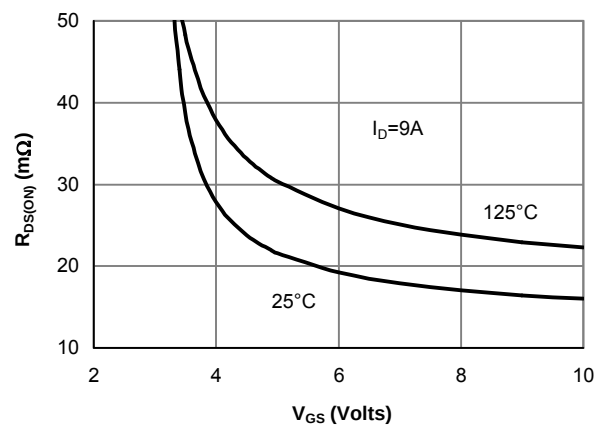


Figure 5: On-Resistance vs. Gate-Source Voltage

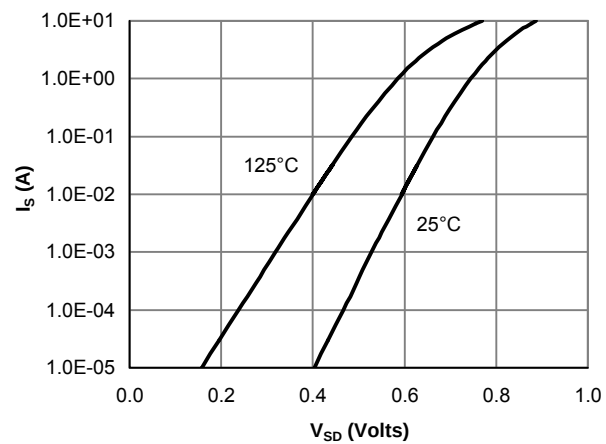


Figure 6: Body-Diode Characteristics

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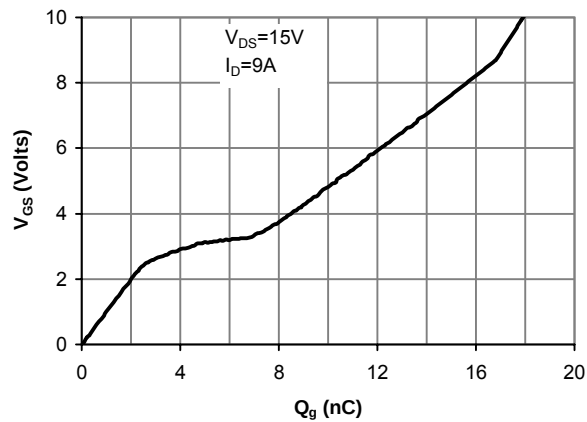


Figure 7: Gate-Charge Characteristics

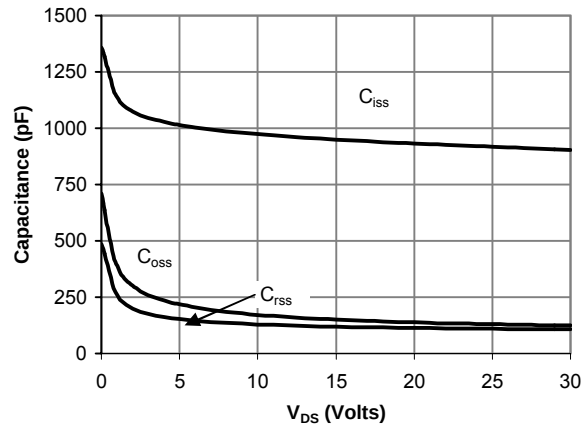


Figure 8: Capacitance Characteristics

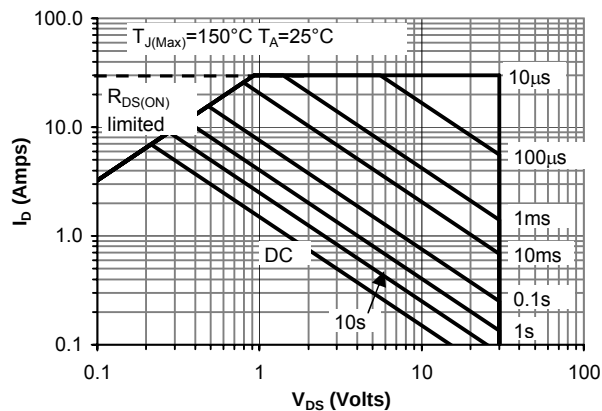


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

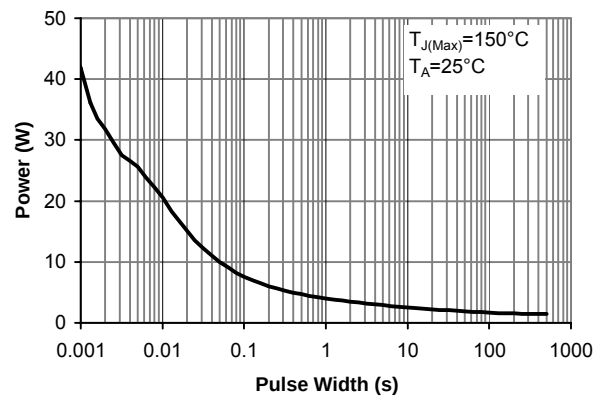


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

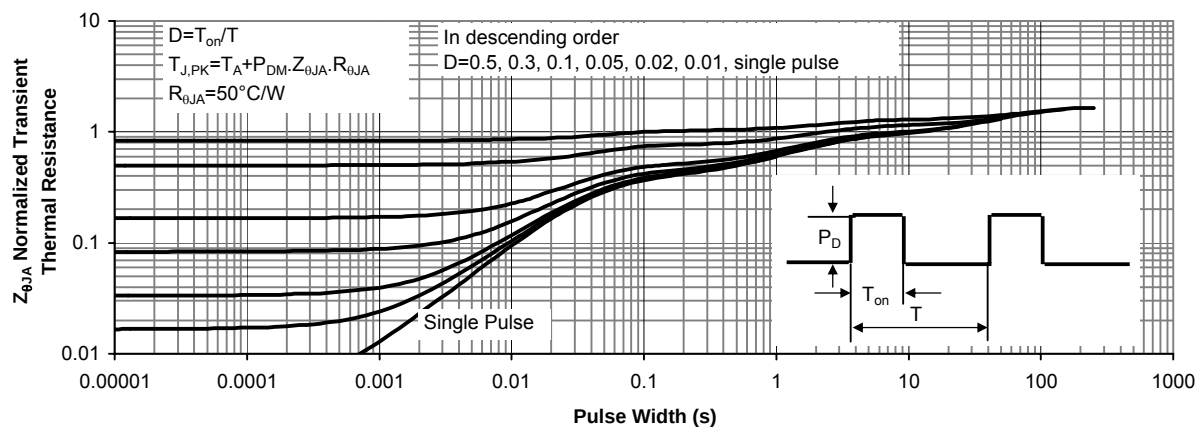


Figure 11: Normalized Maximum Transient Thermal Impedance